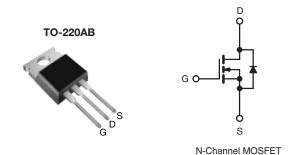


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	500				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V 0.28				
Q _g (Max.) (nC)	130				
Q _{gs} (nC)	33				
Q _{gd} (nC)	59				
Configuration	Single				



FEATURES

• Low Gate Charge Qq results in Simple Drive



• Improved Gate, Avalanche and Dynamic dV/dt RoHS Ruggedness

- Fully Characterized Capacitance and Avalanche Voltage and Current
- Low t_{rr} and Soft Diode Recovery
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching
- ZVS and High Frequency Circuit
- PWM Inverters

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRFB17N50LPbF		
	SiHFB17N50L-E3		
SnPb	IRFB17N50L		
SIFD	SiHFB17N50L		

ABSOLUTE MAXIMUM RATINGS (T_C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	V	
Gate-Source Voltage			V_{GS}	± 30	V	
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		16	А	
	V _{GS} at 10 V	T _C = 100 °C	I _D	11		
Pulsed Drain Current ^a			I _{DM}	64		
Linear Derating Factor				1.8	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	390	mJ	
Repetitive Avalanche Current ^a			I _{AR}	16	Α	
Repetitive Avalanche Energy ^a			E _{AR}	22	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	220	W	
Peak Diode Recovery dV/dt ^c			dV/dt	13	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque			-	1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting T_J = 25 °C, L = 3.0 mH, R_g = 25 Ω , I_{AS} = 16 A (see fig. 12).
- c. $I_{SD} \leq 16~A$, $dI/dt \leq 347~A/\mu s, V_{DD} \leq V_{DS}, T_J \leq 150~^{\circ}C.$
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFB17N50L, SiHFB17N50L

Vishay Siliconix



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.56			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static								
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.6	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$		-	5.0	V	
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 30 V		-	-	± 100	nA	
Zana Oata Valta aa Dusin Ouwant		V _{DS} = 500 V, V _{GS} = 0 V		-	-	50	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	2.0	mA	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 9.9 A ^b	-	0.28	0.32	Ω	
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 9.9 A ^b	11	-	-	S	
Dynamic								
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	2760	-		
Output Capacitance	C _{oss}]	$V_{DS} = 25 \text{ V},$	-	325	-		
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	37	-	,r	
Outro d Connectors	0	$V_{GS} = 0 V$	V _{DS} = 1.0 V , f = 1.0 MHz	-	3690	-	pF	
Output Capacitance	C_{oss}	V _{GS} = 0 V	V _{DS} = 400 V , f = 1.0 MHz	-	84	-		
Effective Output Capacitance	Coss eff.	V _{GS} = 0 V	V _{DS} = 0 V to 400 V ^c	-	159	-		
Total Gate Charge	Qg			-	-	130	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 16 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 ^b		-	33		
Gate-Drain Charge	Q_{gd}	1	goo ng. o ana .o	-	-	59		
Turn-On Delay Time	t _{d(on)}		V_{DD} = 250 V, I_D = 16 A, R_g = 7.5 Ω , see fig. 10 ^b		21	-	- ns	
Rise Time	t _r	V _{DD} =			51	-		
Turn-Off Delay Time	t _{d(off)}	$R_g =$			50	-		
Fall Time	t _f	1	1			-	1	
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET sym	ibol	-	-	16		
Pulsed Diode Forward Current ^a	I _{SM}	showing the integral reverse p - n junction diode		-	-	64	А	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 16 A, V _{GS} = 0 V ^b		-	-	1.5	V	
	T _J = 25 °C		-	170	250			
Body Diode Reverse Recovery Time	t _{rr}	T ₁ = 125 °C		-	220	330	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	T _J = 25 °C	l _E = 16 A. dl/dt = 100 A/us ^b		470	710		
		T _J = 125 °C	1	-	810	1210	nC	
Reverse Recovery Current	I _{RRM}		1	-	7.3	11	Α	
Forward Turn-On Time	t _{on}	Intrinsic to	ırn-on time is negligible (turn-	on is dor	ninated b	v Le and	[[[]]	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width $\leq 300 \,\mu s$; duty cycle $\leq 2 \,\%$.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

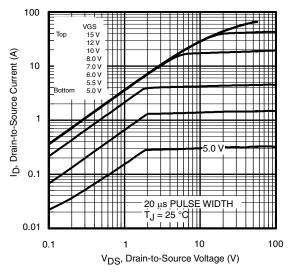


Fig. 1 - Typical Output Characteristics

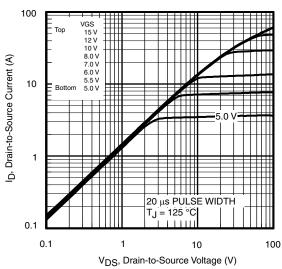


Fig. 2 - Typical Output Characteristics

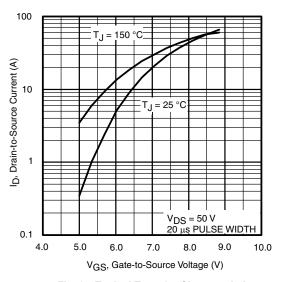


Fig. 3 - Typical Transfer Characteristics

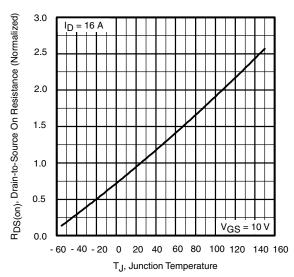


Fig. 4 - Normalized On-Resistance vs. Temperature



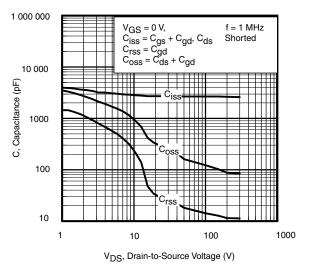


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

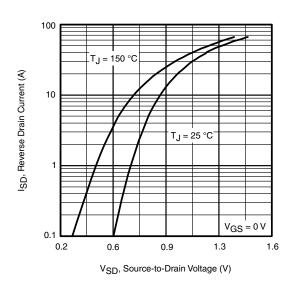


Fig. 7 - Typical Source-Drain Diode Forward Voltage

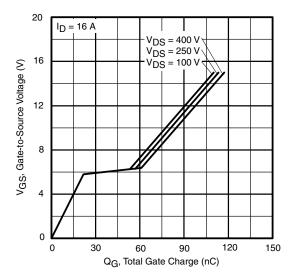


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

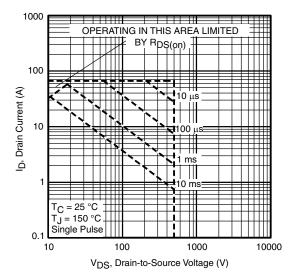


Fig. 8 - Maximum Safe Operating Area

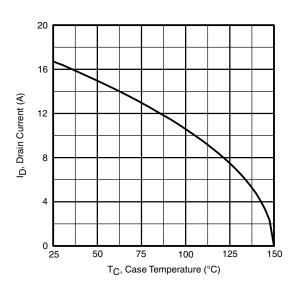


Fig. 9 - Maximum Drain Current vs. Case Temperature

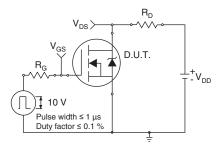


Fig. 10a - Switching Time Test Circuit

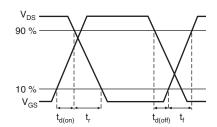


Fig. 10b - Switching Time Waveforms

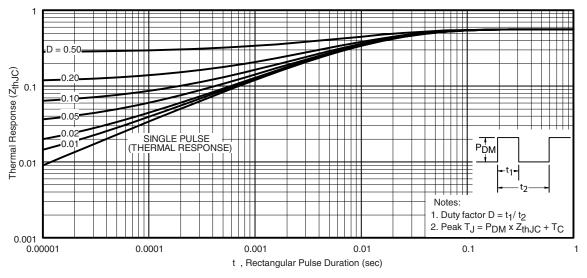


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



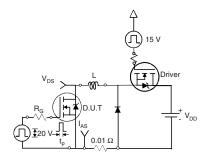


Fig. 12a - Unclamped Inductive Test Circuit

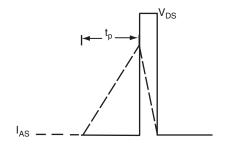


Fig. 12b - Unclamped Inductive Waveforms

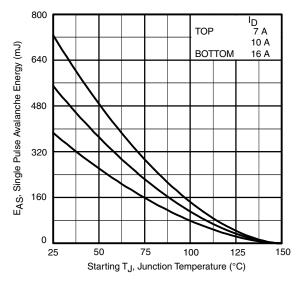


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

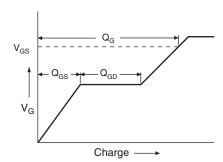


Fig. 13a - Basic Gate Charge Waveform

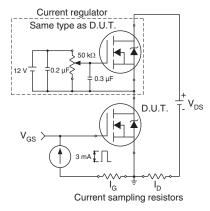
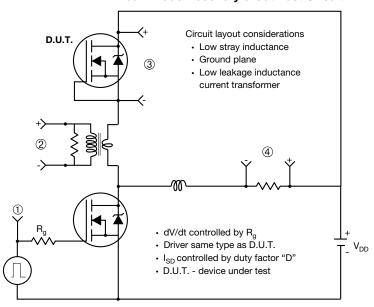


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



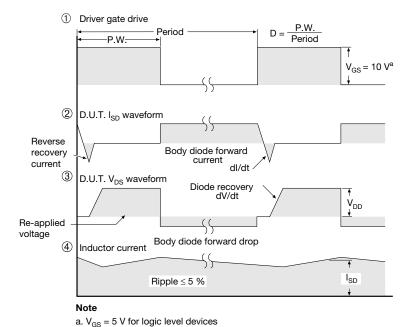


Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91098.





TO-220-1



DIM	MILLIN	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
E	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 \bullet $M^{\star}=0.052$ inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



Legal Disclaimer Notice

Vishay

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.